

Deep level defect spectroscopy in reduced dimension semiconductor materials and devices

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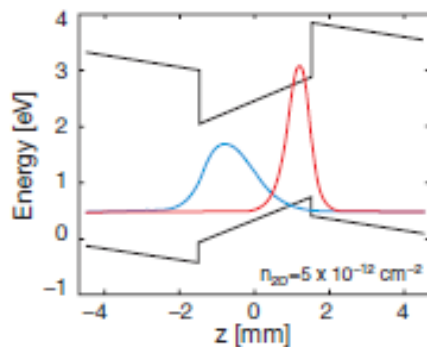


Green-gap limits InGaN/GaN LEDs and LDs

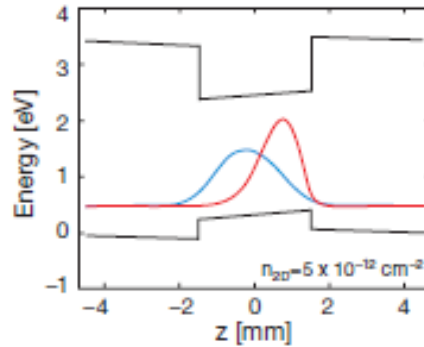
- “Green gap” persists in non-polar LEDs, LDs
 - Efficiency drops with increasing λ
 - Not completely explained by Quantum-confined Stark Effect (QCSE)
 - Suggests a contribution from defects

Green-yellow gap more than QCSE

c-plane



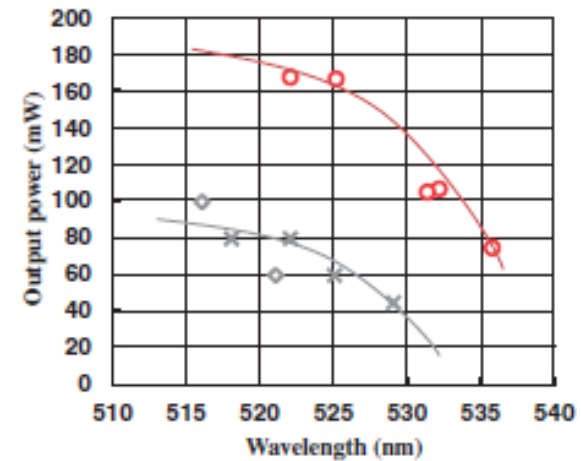
Semi-polar



Ulrich T. Schwarz and
Wolfgang G. Scheibenzuber

Optics & Photonics News

Semi-polar LD power vs. λ



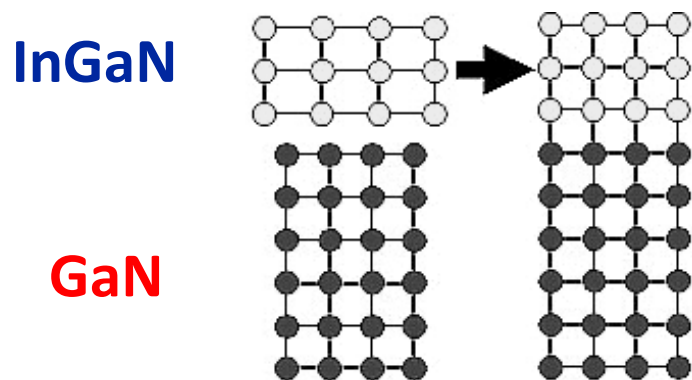
Takagi *et al.* *Applied Physics Express* 5 (2012) 082102

Defects and InGaN/GaN MQWs

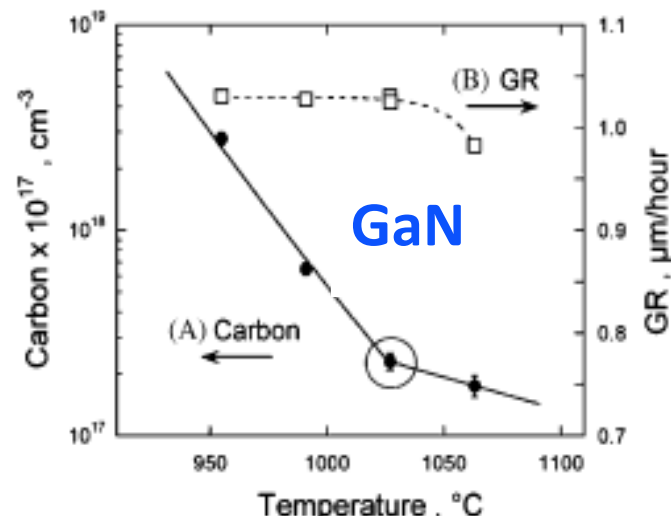
InGaN/GaN MQWs have potential for high defect density:

- Highly mis-matched epitaxy
- Heterostructures force trade-offs between alloy growth conditions

Mis-matched epitaxy and strain



Non-ideal growth conditions



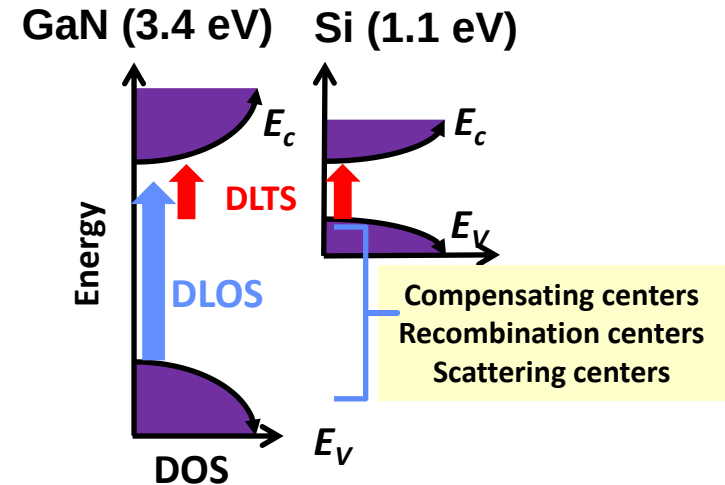
Koleske *et al.*, JCG 242 55 (2002)

Defects formation more likely with increasing indium, λ

Quantitative LED defect spectroscopy is difficult

Challenge: Wide (In)GaN band gap (2.3 – 3.4 eV)

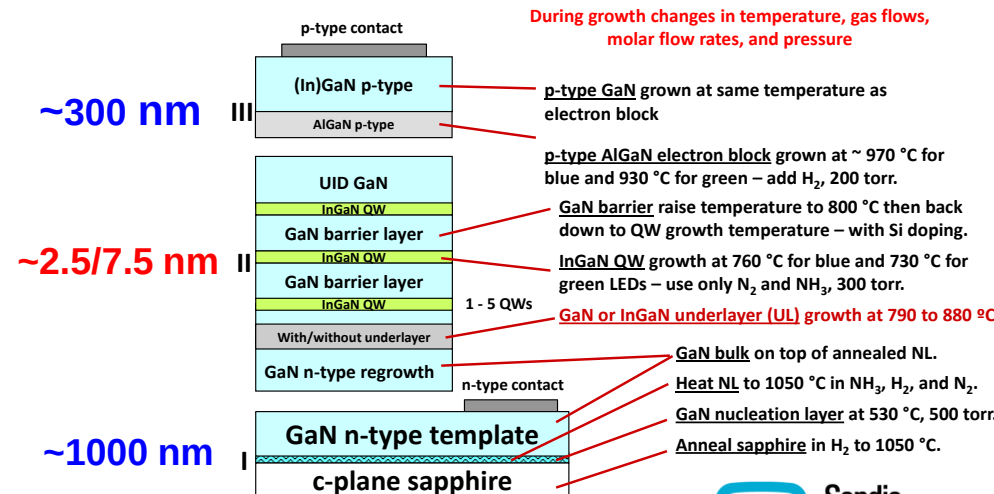
- Thermal emission rates decrease exponentially with trap energy



Challenge: Needle in a “haystack”

- Need nanoscale depth resolution to differentiate QW and QB defects

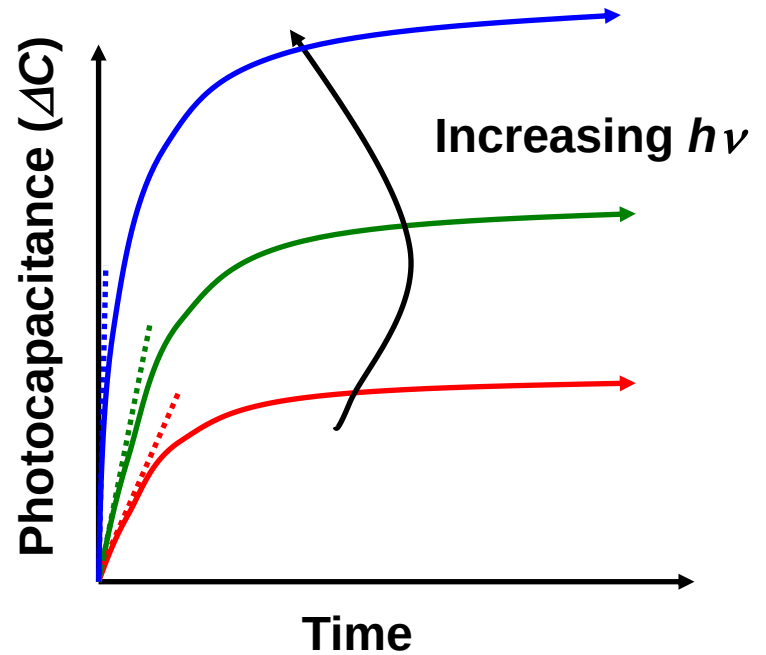
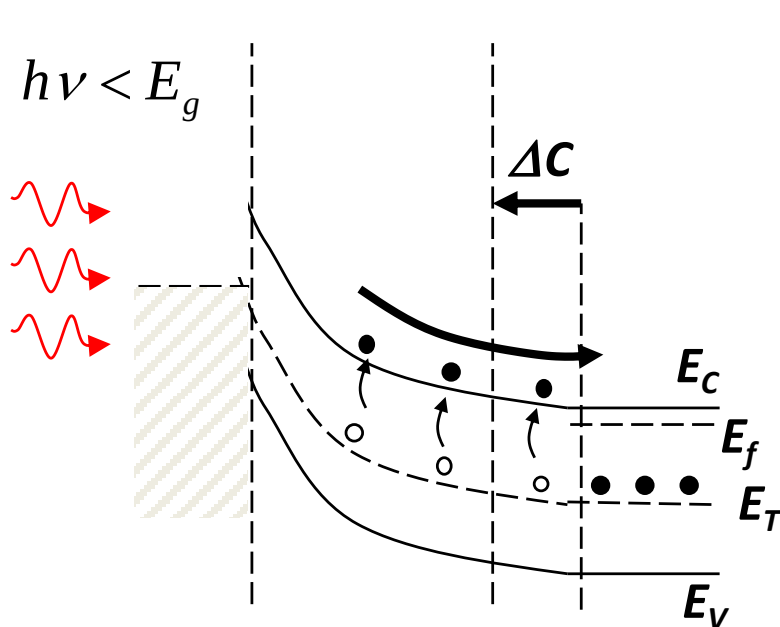
LED design - NOT TO SCALE!



Deep Level Optical Spectroscopy

“Thin film” Deep Level Optical Spectroscopy (DLOS)¹

- Photocapacitance technique
- Sub-band gap optical stimulation to photoionize defect levels
- Quantify non-radiative defect level energy



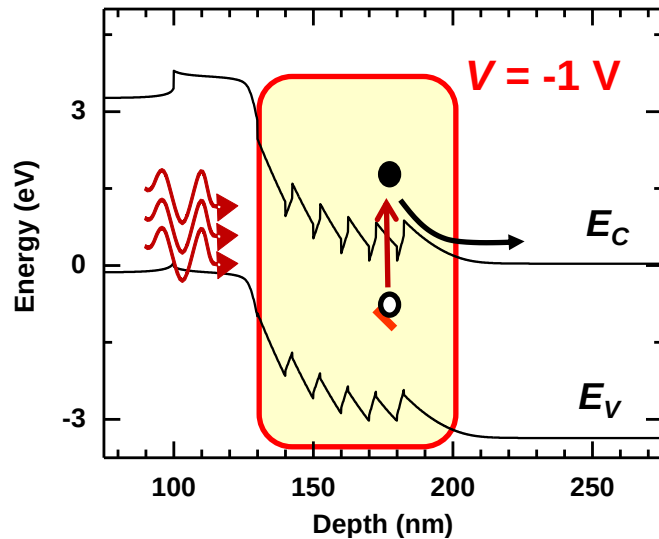
- DLOS only sensitive to depleted regions

1. Chantre et al. PRB 23, 5335 (1981).

- Optical cross-section $\sigma^o = e^o / \Phi = \alpha / N_t$
- $\sigma^o(h\nu) \propto dC(t)/dt|_{t=0}$
- Address defect density later...

DLOS provides depth resolution in LEDs

LED MQW 1D-SP calculations*



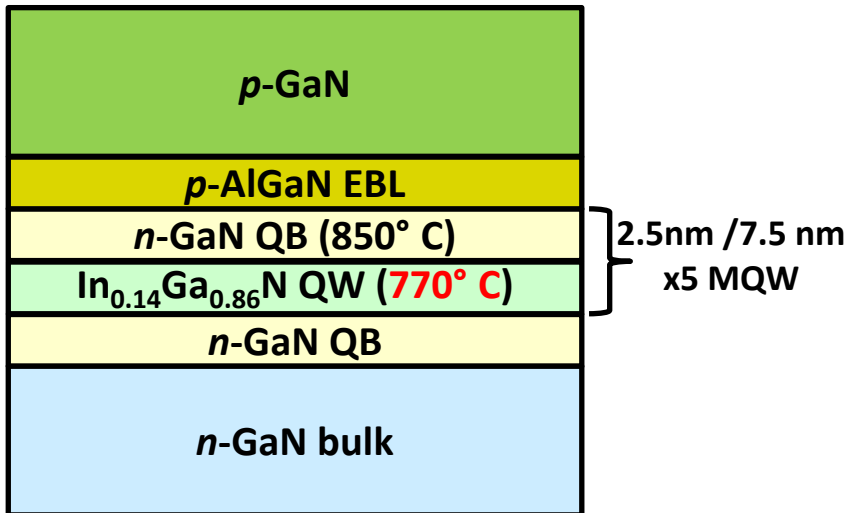
*G. Snider UND

$V = -1\text{ V}$: DLOS selective to the MQW region

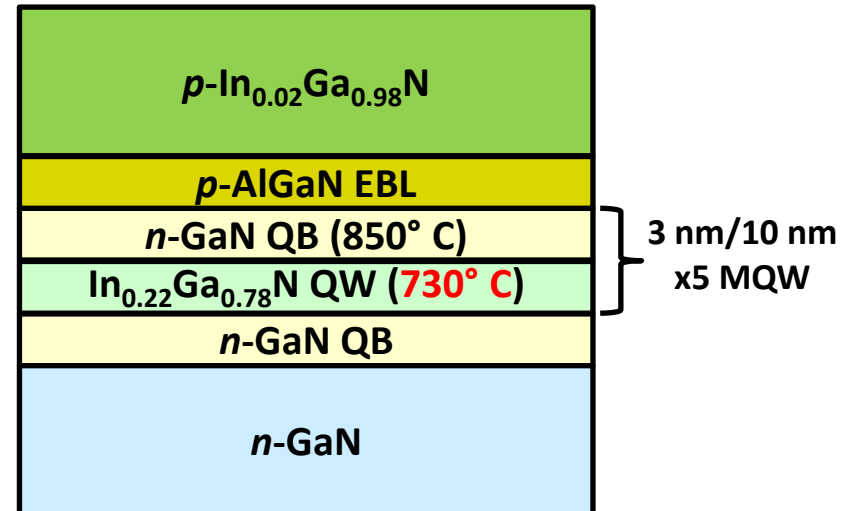
➤ Detect both InGaN QW and GaN QB defects

Sample description

450 nm InGaN/GaN LED



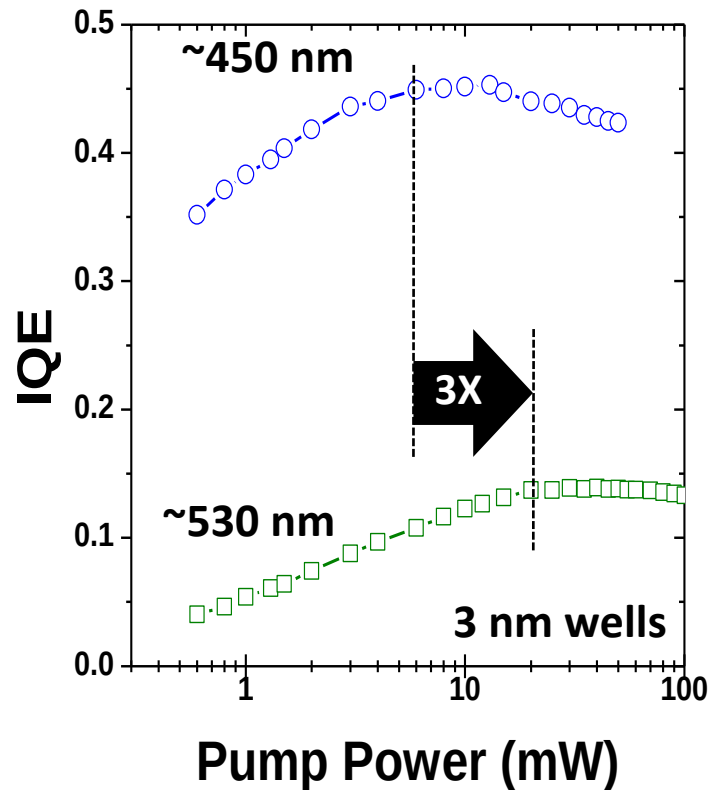
530 nm InGaN/GaN LED



➤ Reduced T_g for green LED QWs

Green LED IQE indicates excess defects

LED IQE vs. optical pump power

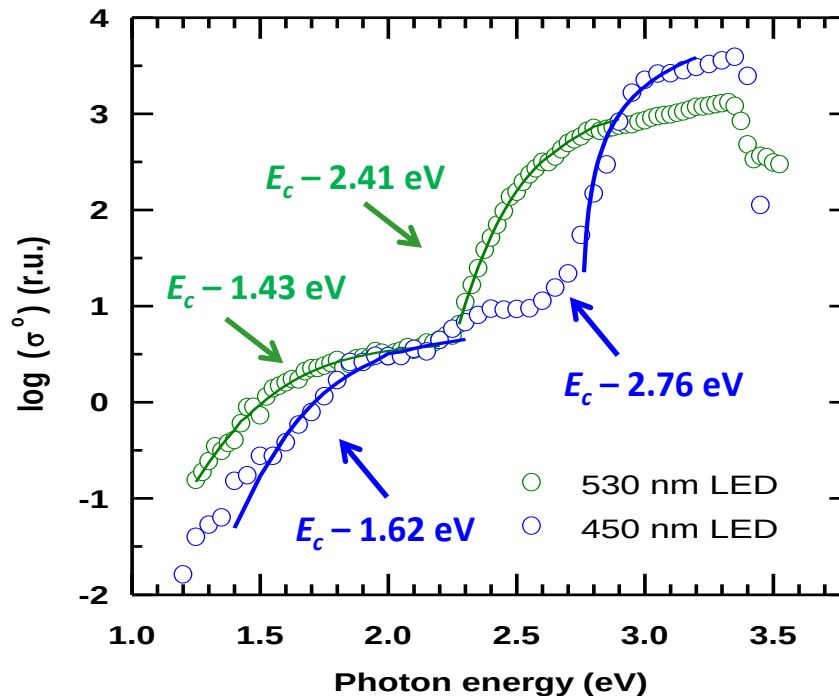


$$n_p = \sqrt{A/C}$$

- IQE peak shifts to larger power with increasing indium
- Suggests additional non-radiative recombination

LED QW deep level evolve with Indium content

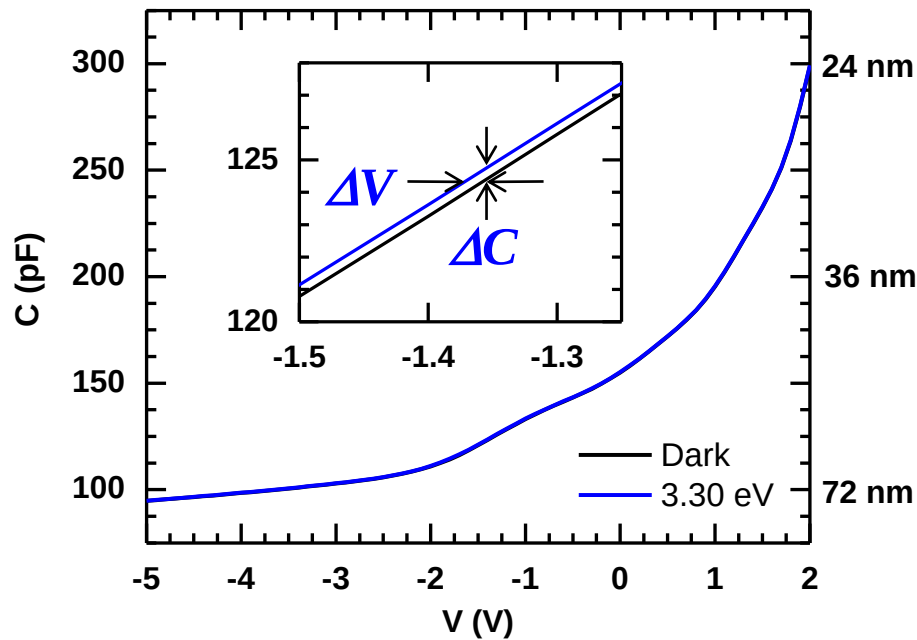
LED QW DLOS vs. indium content



- InGaN band edges demonstrate QW sensitivity
- Near- E_v and near mid-band gap deep levels
- Identify QW defect levels from red-shift with increasing indium

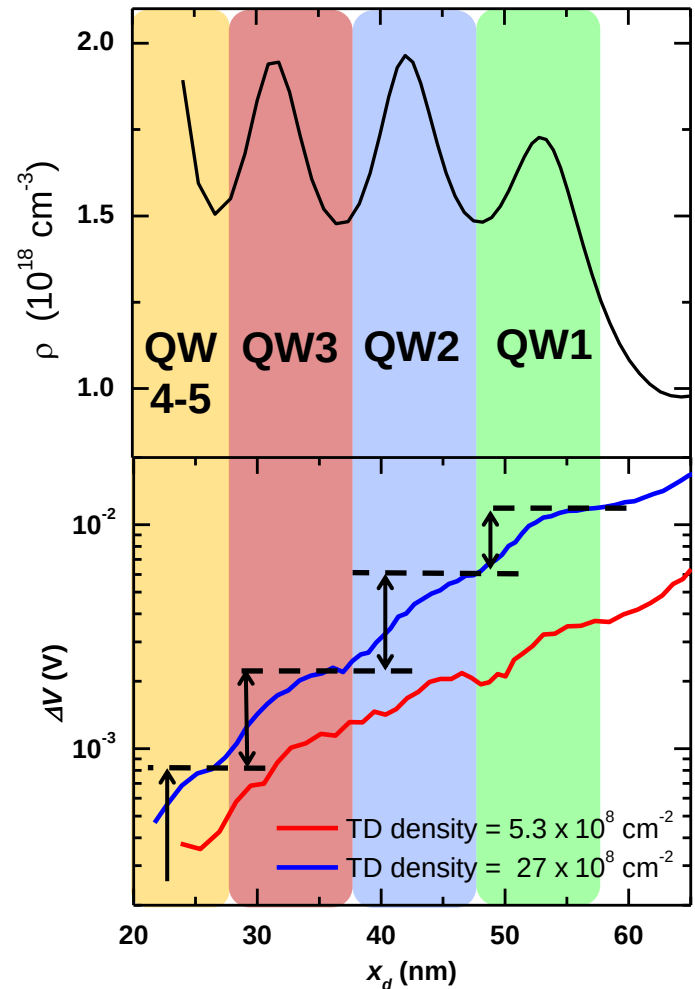
Lighted-CV quantifies QW defect density

Lighted C-V



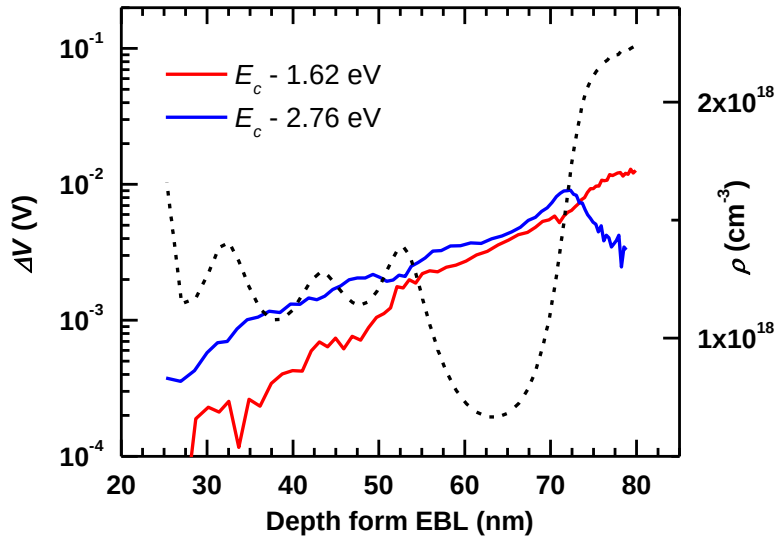
$$\Delta V = \frac{q}{\epsilon} \int_{x_1}^{x_2} x N_t dx$$

Depth profile of MQW defects

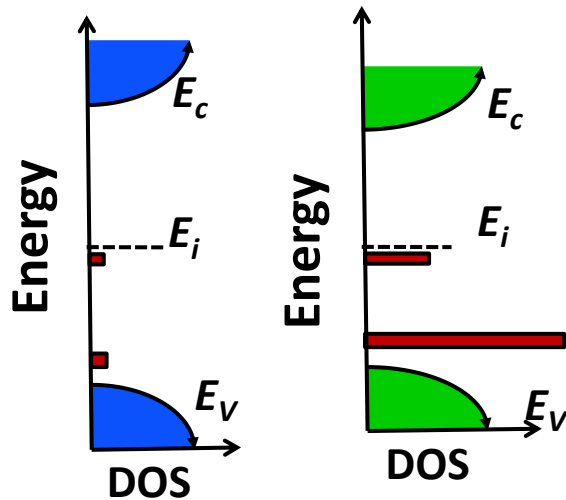


QW deep level defect density

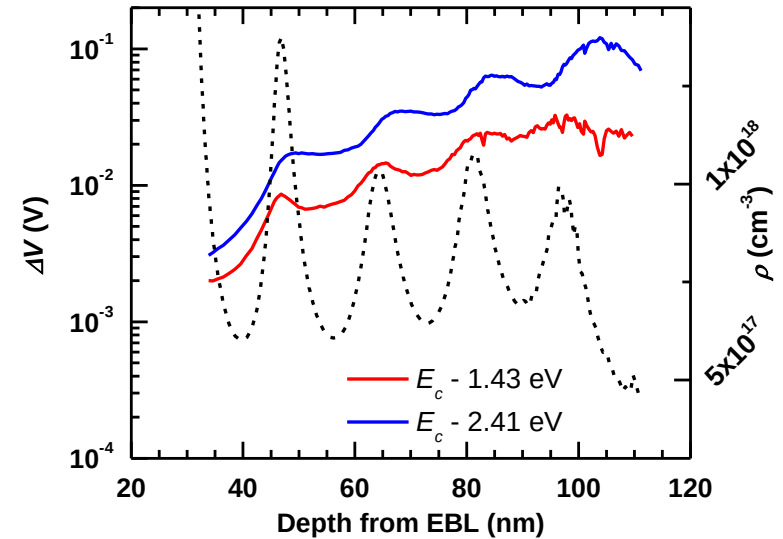
LCV of 450 LED



$\text{In}_{0.14}\text{G}_{0.86}\text{N QW}$ $\text{In}_{0.22}\text{Ga}_{0.78}\text{N QW}$



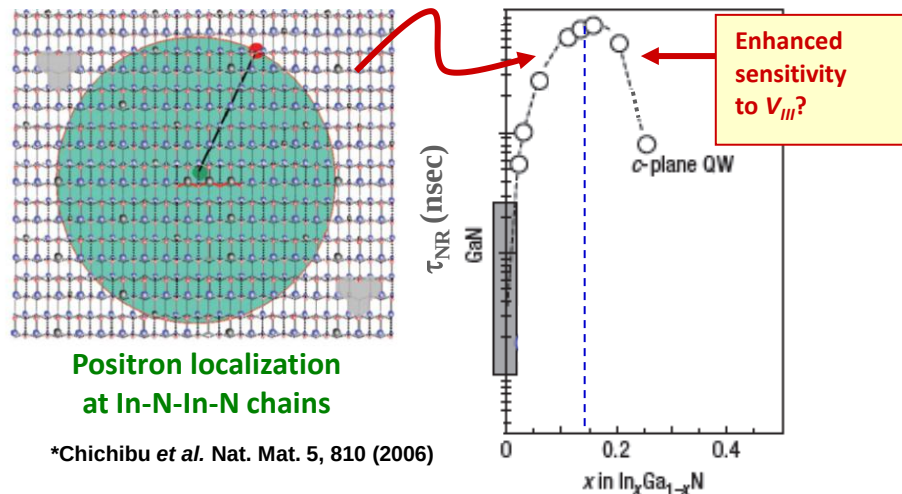
LCV of 530 LED



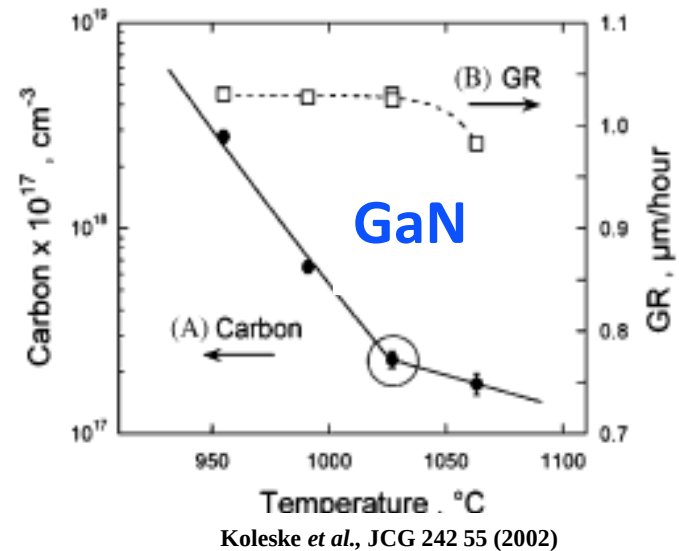
Defect Level (eV)	N_t (cm^{-3})	ΔN_t
$E_c - 1.62$	4.1×10^{15}	4.4x
$E_c - 1.43$	1.8×10^{16}	
$E_c - 2.76$	4.4×10^{15}	13x
$E_c - 2.43$	5.5×10^{16}	

Possible origin of QW defects – V_{III} or carbon

V_{III} density increases with indium

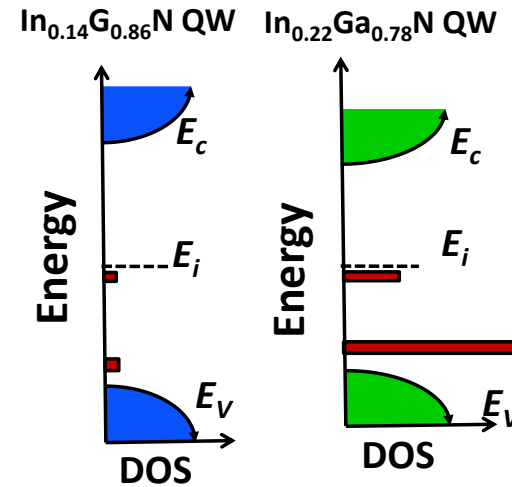
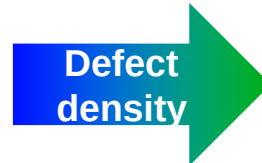
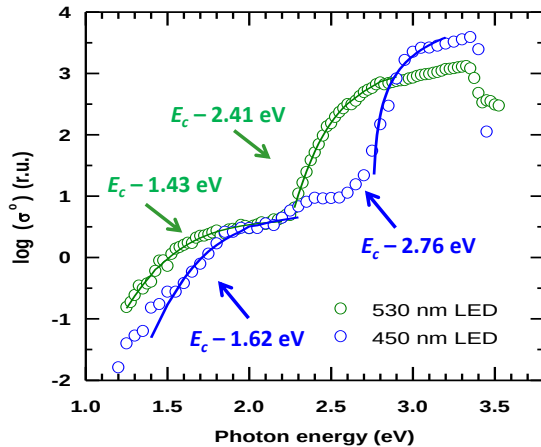


$[C]$ increases with lower T_g

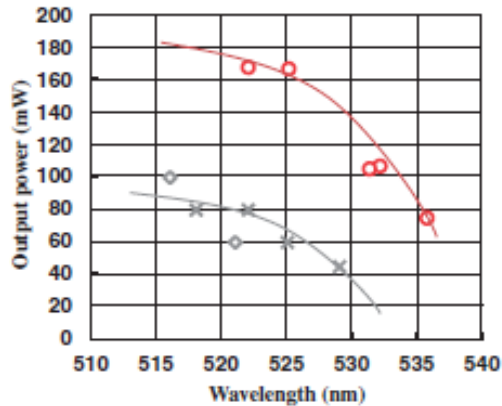


- V_{III} and carbon are well known non-radiative recombination centers in GaN
- PAS and PL studies* show that $[V_{III}]$ increases and τ_{NR} decreases with indium
- Reasonable that carbon incorporation increases with reduced QW T_g

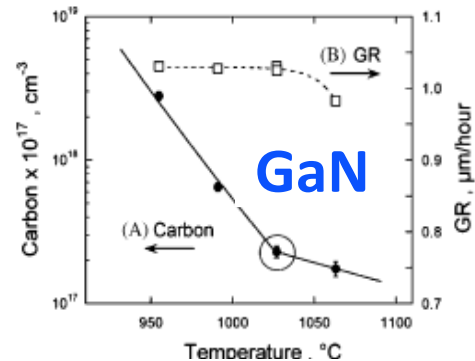
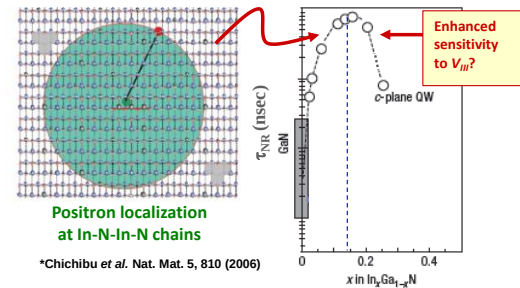
Conclusions



Semi-polar LD power vs. λ



Takagi et al. *Applied Physics Express* 5 (2012) 082102



Koleske et al., *JCG* 242 55 (2002)